

F7306Q-VB Datasheet Dual P-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | | |
|---------------------|------------------------------------|------------------------------------|-----------------------|--|--|--|--|
| V _{DS} (V) | $R_{DS(on)}\left(\Omega\right)$ | I _D (A) ^{d, e} | Q _g (Typ.) | | | | |
| - 30 | 0.035 at V _{GS} = - 10 V | - 7.3 | 17 nC | | | | |
| - 30 | 0.045 at V _{GS} = - 4.5 V | - 6.3 | 17 110 | | | | |

FEATURES

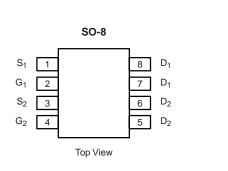
- Halogen-free
- Trench Power MOSFET
- 100 % UIS Tested

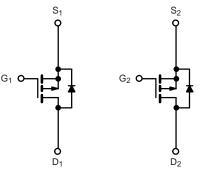


ROHS

APPLICATIONS

· Load Switches





P-Channel MOSFET

P-Channel MOSFET

| Parameter | Symbol | Limit | Unit | |
|---|-----------------------------------|-------------------|-----------------------|-----|
| Drain-Source Voltage | V _{DS} | - 30 | V | |
| Gate-Source Voltage | V _{GS} | ± 20 | V | |
| | T _C = 25 °C | | - 7.3 ^e | |
| Continuous Drain Current (T _{.1} = 150 °C) | T _C = 70 °C | | - 7.0 ^e | |
| Continuous Diam Curient (1) = 130 °C) | T _A = 25 °C | l _D | - 7.3 ^{a, b} | |
| | T _A = 70 °C | | - 5.9 ^{a, b} | |
| Pulsed Drain Current | I _{DM} | - 32 ^e | Α | |
| | T _C = 25 °C | | - 4.1 | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | ls – | - 2.0 ^{a, b} | |
| Avalanche Current | 1 0411 | I _{AS} | - 20 | |
| Single-Pulse Avalanche Energy | L = 0.1 mH | E _{AS} | 20 | mJ |
| | T _C = 25 °C | | 5.0 | |
| Manianum Davin Dinain ation | T _C = 70 °C | | 3.2 | 10/ |
| Maximum Power Dissipation | T _A = 25 °C | P _D | 2.5 ^{a, b} | W |
| | T _A = 70 °C | | 1.6 ^{a, b} | |
| Operating Junction and Storage Temperature Rang | T _J , T _{stg} | - 55 to 150 | °C | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{a, c} | t ≤ 10 s | R _{thJA} | 38 | 50 | °C/W | |
| Maximum Junction-to-Foot | Steady State | R_{thJF} | 20 | 25 | C/VV | |

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under Steady State conditions is 85 °C/W.
- d. Based on $T_C = 25 \, ^{\circ}C$.
- e. Limited by package.



| Parameter | Symbol | rwise noted Test Conditions | Min. | Typ. | Max. | Unit | |
|---|----------------------------------|--|---------|----------|------------|--------|--|
| Static | Symbol | rest conditions | IVIIII. | тур. | IVIAX. | Unit | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = - 250 μA | - 30 | | l | V | |
| V _{DS} Temperature Coefficient | ΔV _{DS} /T _J | VGS = 0 V, 1D = 230 μΛ | - 30 | - 31 | | v | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = - 250 μA | | 4.5 | | mV/°C | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$ | - 1.0 | 4.5 | - 3.0 | V | |
| | . , | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ $V_{DS} = 0 \text{V}, V_{GS} = \pm 20 \text{V}$ | - 1.0 | | | - | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ | | | ± 100 | nA | |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$ | | | - 1 - 5 | μΑ | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$ | - 30 | | | Α | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = -10 V, I _D = -6.3 A | | 0.035 | | Ω | |
| | | $V_{GS} = -4.5 \text{ V}, I_D = -6.2 \text{ A}$ | | 0.040 | | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = - 10 V, I _D = - 6.1 A | | 23 | | S | |
| Dynamic ^b | | | | | T | T | |
| Input Capacitance | C _{iss} | | | 1350 | | | |
| Output Capacitance | C _{oss} | $V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 215 | | pF | |
| Reverse Transfer Capacitance | C _{rss} | | | 185 | | | |
| Total Gate Charge | Q_g | $V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -6.1 \text{ A}$ | | 32 15 | 50 25 | | |
| Gate-Source Charge | Q _{gs} | V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 6.1 A | | 4 | 20 | nC | |
| Gate-Drain Charge | Q _{gd} | , bo , go , b | | 7.5 | | | |
| Gate Resistance | R _g | f = 1 MHz | | 5.8 | | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 10 | 15 | | |
| Rise Time | t _r | $V_{DD} = -15 \text{ V}, R_1 = 15 \Omega$ | | 8 | 15 | | |
| Turn-Off DelayTime | t _{d(off)} | $I_D \cong -1 \text{ A}, V_{GEN} = -10 \text{ V}, R_q = 1 \Omega$ | | 45 | 70 | | |
| Fall Time | t _f | 9 J | | 12 | 25 | | |
| Turn-On Delay Time | t _{d(on)} | | | 42 | 70 | ns | |
| Rise Time | t _r | $V_{DD} = -15 \text{ V}, R_1 = 15 \Omega$ | | 35 | 60 | = = | |
| Turn-Off DelayTime | t _{d(off)} | $I_D \cong -1 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_q = 1 \Omega$ | | 40 | 70 | | |
| Fall Time | t _f | g | | 16 | 30 | | |
| Drain-Source Body Diode Characterist | ics | | | | | | |
| Continous Source-Drain Diode Current | I _S | T _C = 25 °C | | | - 4.1 | | |
| Pulse Diode Forward Current | I _{SM} | Ŭ | | | - 32 | Α | |
| Body Diode Voltage | V _{SD} | I _S = -2 A, V _{GS} = 0 V | | - 0.75 | - 1.2 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | 3 | | 34 | 60 | ns | |
| Body Diode Reverse Recovery Charge Q _r | | | | 22 | 40 | nC | |
| Reverse Recovery Fall Time | t _a | $I_F = -2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °C$ | | 11 | - | | |
| Reverse Recovery Rise Time | t _b | | | 23 | | ns | |

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

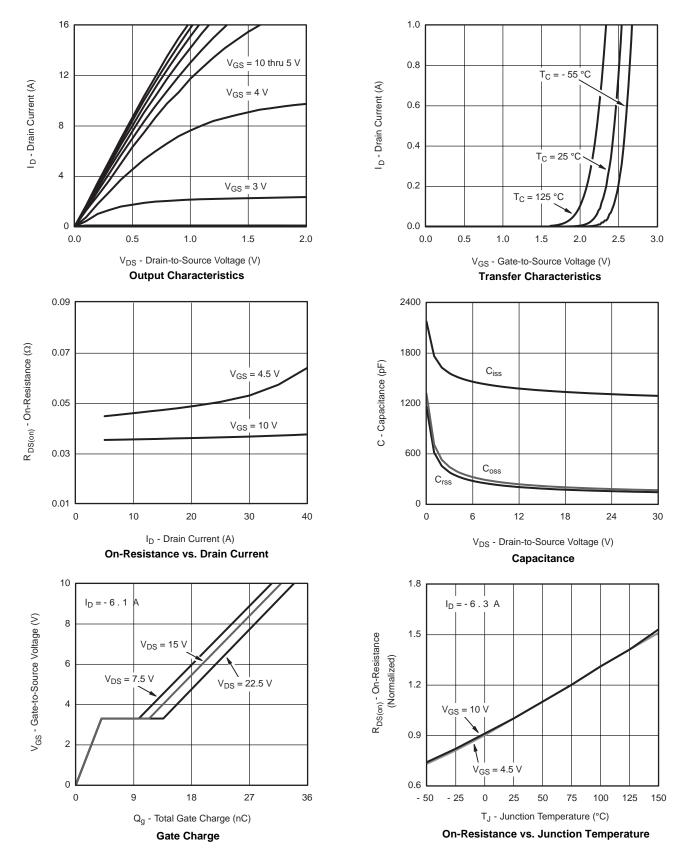
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a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.



TYPICAL CHARACTERISTICS 25 C, unless otherwise noted





 $I_D = -6.3 A$

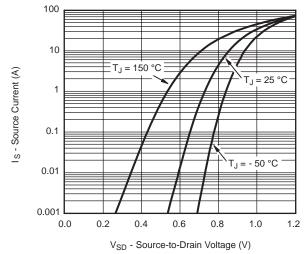
T_J = 125 °C

T_J = 25 °C

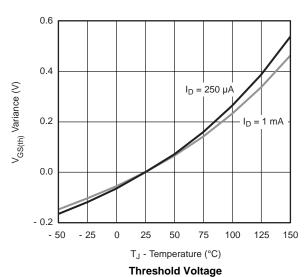
8

10

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Source-Drain Diode Forward Voltage



0.00 0 2

0.10

0.08

0.06

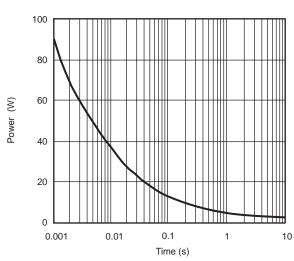
0.04

0.02

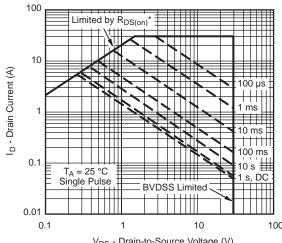
 $R_{DS(on)}$ - On-Resistance (Ω)

V_{GS} - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage

6



Single Pulse Power, Junction-to-Ambient



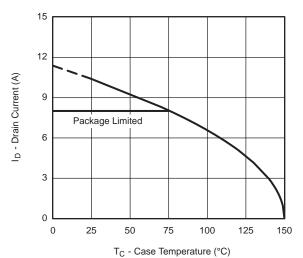
V_{DS} - Drain-to-Source Voltage (V)

* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

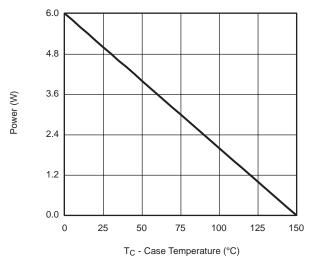
Safe Operating Area

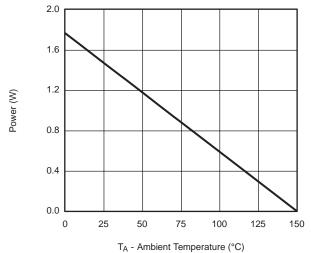


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted









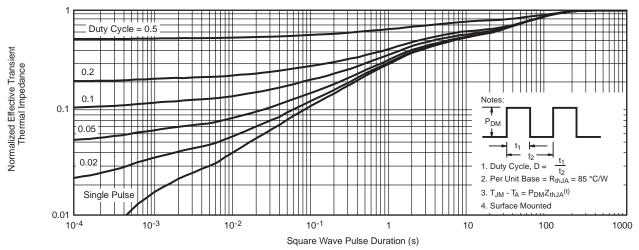
Power, Junction-to-Foot

Power Derating, Junction-to-Ambient

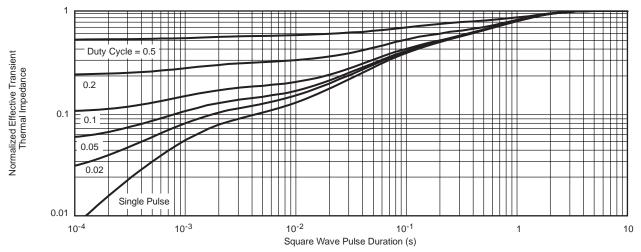
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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SOIC (NARROW): 8-LEADJEDEC Part Number: MS-012







| | MILLIM | IETERS | INC | HES | |
|------------------------------|--------|--------|-----------|-------|--|
| DIM | Min | Max | Min | Max | |
| Α | 1.35 | 1.75 | 0.053 | 0.069 | |
| A ₁ | 0.10 | 0.20 | 0.004 | 0.008 | |
| В | 0.35 | 0.51 | 0.014 | 0.020 | |
| С | 0.19 | 0.25 | 0.0075 | 0.010 | |
| D | 4.80 | 5.00 | 0.189 | 0.196 | |
| E | 3.80 | 4.00 | 0.150 | 0.157 | |
| е | 1.27 | BSC | 0.050 BSC | | |
| Н | 5.80 | 6.20 | 0.228 | 0.244 | |
| h | 0.25 | 0.50 | 0.010 | 0.020 | |
| L | 0.50 | 0.93 | 0.020 | 0.037 | |
| q | 0° | 8° | 0° | 8° | |
| S | 0.44 | 0.64 | 0.018 | 0.026 | |
| FCN: C-06527-Rev I 11-Sen-06 | | | | | |

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

服务热线:400-655-8788 7



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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